## Application/Control No. Applicant(s)/Patent Under Reexamination 09/625,843 HIYAMA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Yogesh K. Aggarwal 2622 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 08-2005 348/362 US-6,930,722 Nakamura et al. Α US-В С US-US-D US-Ę US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name · Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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